

FAIRCHILD SEMICONDUCTOR

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3469674 FAIRCHILD SEMICONDUCTOR

84D 27412 D



PE8050/PE8550 7-29-23

NPN-PNP General Purpose
Complementary Amplifiers & Output
Drivers

- V_{CEO} ... 25 V (Min)
- h_{FE} ... Outstanding Beta Linearity to 1.0 A
- Three h_{FE} Groups
- Guaranteed SOA
- Complements ... PE8050, (NPN), PE8550, (PNP)

PACKAGE

PE8050	TO-92
PE8550	TO-92

ABSOLUTE MAXIMUM RATINGS (Note 1)

Temperatures

Storage Temperature	-55°C to 150°C
Operating Junction Temperature	150°C

Power Dissipation ($V_{CE} = 8.0$ V) (Notes 2 & 3)

Total Dissipation at	
25°C Ambient Temperature	0.625 W
25°C Case Temperature	1.0 W

Voltages & Currents

V_{CEO} Collector to Emitter Voltage (Note 4)	25 V
V_{CBO} Collector to Base Voltage	30 V
V_{EBO} Emitter to Base Voltage	6.0 V
I_C Collector Current (Continuous)	1.5 A
I_C Collector Current (Pulsed)	1.5 A

ELECTRICAL CHARACTERISTICS (25°C Ambient Temperature unless otherwise noted) (Note 6)

SYMBOL	CHARACTERISTIC	MIN	MAX	UNITS	TEST CONDITIONS
V_{CEO}	Collector to Emitter Breakdown Voltage (Note 5)	25		V	$I_C = 10$ mA, $I_E = 0$
V_{CBO}	Collector to Base Breakdown Voltage	30		V	$I_C = 100$ μ A, $I_E = 0$
V_{EBO}	Emitter to Base Breakdown Voltage	6.0		V	$I_E = 100$ μ A, $I_C = 0$
I_{CBO}	Collector Cutoff Current		100	nA	$V_{CB} = 20$ V, $I_E = 0$
h_{FE}	DC Current Gain (Note 5)	50 65 65 40	200 200 200 200		$I_C = 10$ mA, $V_{CE} = 1.0$ V $I_C = 100$ mA, $V_{CE} = 1.0$ V $I_C = 500$ mA, $V_{CE} = 1.0$ V $I_C = 1.0$ A, $V_{CE} = 1.0$ V $I_C = 100$ mA, $V_{CE} = 1.0$ V
	Gain Grouping A	65	130		
	Gain Grouping B	85	160		
	Gain Grouping C	120	200		

NOTES:

1. These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired.
2. These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.
3. These ratings give a maximum junction temperature of 150°C and (TO-92) junction-to-case thermal resistance of 125°C/W (derating factor of 5.0 mW/°C); junction-to-ambient thermal resistance of 125°C/W (derating factor of 8.0 mW/°C).
4. Rating refers to a high current point where collector to emitter voltage is lowest.
5. Pulse conditions: length = 300 μ s; duty cycle = 1%.
6. For product family characteristic curves, refer to Curve Set T124 for PE8050 & T202 for PE8550.

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PE8050/PE8550

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ELECTRICAL CHARACTERISTICS (25° C Ambient Temperature unless otherwise noted) (Note 6)

SYMBOL	CHARACTERISTIC	MIN	MAX	UNITS	TEST CONDITIONS
h_{FE1}/h_{FE2}	Beta Ratio at Two Currents	0.8	1.8		$I_{C1} = 100 \text{ mA}, I_{C2} = 800 \text{ mA}, V_{CE} = 1.0 \text{ V}$
h_{FE3}/h_{FE4}	Beta Ratio at Two Currents	0.8	1.5		$I_{C1} = 150 \text{ mA}, I_{C4} = 500 \text{ mA}, V_{CE} = 1.0 \text{ V}$
h_{fe}	High Frequency Current Gain	1.0			$I_C = 50 \text{ mA}, V_{CE} = 10 \text{ V}, f = 100 \text{ MHz}$
$V_{CE(\text{sat})}$	Collector to Emitter Saturation Voltage (Note 5)		0.15 0.5	V V	$I_C = 200 \text{ mA}, I_B = 20 \text{ mA}$ $I_C = 1.0 \text{ A}, I_B = 100 \text{ mA}$
$V_{BE(\text{sat})}$	Base to Emitter Saturation Voltage (Note 5)		0.9 1.2	V V	$I_C = 200 \text{ mA}, I_B = 20 \text{ mA}$ $I_C = 1.0 \text{ A}, I_B = 100 \text{ mA}$
C_{cb}	Collector to Base Capacitance		40	pF	$V_{CB} = 10 \text{ V}, I_C = 0, f = 1.0 \text{ MHz}$

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PN918/MPS918/FTSO918 T-31/23
PN3563/MPS3563/FTSO3563

NPN Small Signal High Frequency
 Amplifiers & Oscillators

- G_{PE} ... 15 dB (Min) @ 200 MHz (PN/FTSO918)
- C_{OB} ... 1.7 pF (Max) @ 10 V
- NF ... 6.0 dB (Max) @ 60 MHz

	PACKAGE
PN918	TO-92
PN3563	TO-92
MPS918	TO-92
MPS3563	TO-92
FTSO918	TO-236AA/AB
FTSO3563	TO-236AA/AB

ABSOLUTE MAXIMUM RATINGS (Note 1)**Temperatures**

Storage Temperature	-55°C to 150°C
Operating Junction Temperature	150°C

Power Dissipation (Notes 2 & 3)

	PN/MPS	FTSO
Total Dissipation at		
25°C Ambient Temperature	0.625 W	0.350 W*
65°C Ambient Temperature	0.300 W	
25°C Case Temperature	1.0 W	

	3563	918
V_{CEO} Collector to Emitter Voltage	12 V	12 V
(Note 4)		
V_{CBO} Collector to Base Voltage	30 V	30 V
V_{EBO} Emitter to Base Voltage	2.0 V	3.0 V
I_C Collector Current	50 mA	50 mA

ELECTRICAL CHARACTERISTICS (25°C Ambient Temperature unless otherwise noted) (Note 6)

SYMBOL	CHARACTERISTIC	3563		MPS918		UNITS	TEST CONDITIONS
		MIN	MAX	MIN	MAX		
BV_{CEO}	Collector to Base Breakdown Voltage	30		30		V	$I_C = 100 \mu A, I_E = 0$
						V	$I_C = 10 \mu A, I_E = 0$
BV_{EBO}	Emitter to Base Breakdown Voltage	2.0		3.0		V	$I_E = 10 \mu A, I_C = 0$
I_{CBO}	Collector Cutoff Current		50		10	nA	$V_{CB} = 15 V, I_E = 0$
h_{FE}	DC Current Gain (Note 5)	20	200	20			$I_C = 3.0 \text{ mA}, V_{CE} = 1.0 \text{ V}$
							$I_C = 8.0 \text{ mA}, V_{CE} = 10 \text{ V}$
$V_{CEO(sus)}$	Collector to Emitter Sustaining Voltage (Notes 4 & 5)	12		15		V	$I_C = 3.0 \text{ mA}, I_B = 0$
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage (Note 5)				0.4	V	$I_C = 10 \text{ mA}, I_B = 1.0 \text{ mA}$
$V_{BE(sat)}$	Base to Emitter Saturation Voltage				1.0	V	$I_C = 10 \text{ mA}, I_B = 1.0 \text{ mA}$

NOTES:

- These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired.
- These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.
- These ratings give a maximum junction temperature of 150°C and (TO-92) junction-to-case thermal resistance of 125°C/W (derating factor of 80 mW/°C); junction-to-ambient thermal resistance of 200°C/W (derating factor of 5.0 mW/°C); (TO-236) junction-to-ambient thermal resistance of 357°C/W (derating factor of 2.8 mW/°C).
- Rating refers to a high current point where collector to emitter voltage is lowest.
- Pulse conditions: length = 300 μs; duty cycle ≤ 1%.
- For product family characteristic curves, refer to Curve Set T121.
- * Package mounted on 99.5% alumina 8 mm x 8 mm x 0.6 mm.

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PN918/MPS918/FTSO918 *T-31-23*
PN3563/MPS3563/FTSO3563

ELECTRICAL CHARACTERISTICS (25° C Ambient Temperature unless otherwise noted) (Note 6)

SYMBOL	CHARACTERISTIC	3563		MPS918		UNITS	TEST CONDITIONS
		MIN	MAX	MIN	MAX		
C_{ob}	Output Capacitance		1.7		1.7 3.0	pF	$V_{CB} = 10 \text{ V}, I_E = 0, f = 1.0 \text{ MHz}$ $V_{CB} = 0, I_E = 0, f = 1.0 \text{ MHz}$
C_{ib}	Input Capacitance				2.0	pF	$V_{EB} = 0.5 \text{ V}, I_C = 0, f = 1.0 \text{ MHz}$
h_{fe}	High Frequency Current Gain	6.0	15	6.0			$I_C = 4.0 \text{ mA}, V_{CE} = 10 \text{ V}, f = 100 \text{ MHz}$ $I_C = 8.0 \text{ mA}, V_{CE} = 10 \text{ V}, f = 100 \text{ MHz}$
h_{fe}	Small Signal Current Gain	20	250				$I_C = 8.0 \text{ mA}, V_{CE} = 10 \text{ V}, f = 1.0 \text{ kHz}$
G_{pe}	Available Power Gain (neutralized) (test circuit 254 for MPS918, PN/MPS3563)	14	26	15		dB	$I_C = 6.0 \text{ mA}, V_{CB} = 12 \text{ V}, f = 200 \text{ MHz}$ $I_C = 8.0 \text{ mA}, V_{CE} = 10 \text{ V}, f = 200 \text{ MHz}$
P_o	Power Output (test circuit no. 264)			30		mW	$I_C = 8.0 \text{ mA}, V_{CB} = 15 \text{ V}, f = 500 \text{ MHz}$
η	Collector Efficiency			25		%	$I_C = 8.0 \text{ mA}, V_{CB} = 15 \text{ V}, f = 500 \text{ MHz}$
$r_b' C_c$	Collector to Base Time Constant	8.0	25			pF	$I_C = 8.0 \text{ mA}, V_{CB} = 10 \text{ V}, f = 79.8 \text{ MHz}$
NF	Noise Figure				6.0	dB	$I_C = 1.0 \text{ mA}, V_{CE} = 6.0 \text{ V}, f = 60 \text{ kHz}, R_E = 400 \Omega$

SYMBOL	CHARACTERISTIC	PN918		UNITS	TEST CONDITIONS
		MIN	MAX		
BV_{CBO}	Collector to Base Breakdown Voltage	30		V	$I_C = 10 \mu\text{A}, I_E = 0$
BV_{EBO}	Emitter to Base Breakdown Voltage	3.0		V	$I_E = 10 \mu\text{A}, I_C = 0$
I_{CBO}	Collector Cutoff Current		10 1.0	nA μA	$V_{CB} = 15 \text{ V}, I_E = 0$ $V_{CB} = 15 \text{ V}, I_E = 0, T_A = 150^\circ\text{C}$
h_{FE}	DC Current Gain (Note 5)	20			$I_C = 3.0 \text{ mA}, V_{CE} = 1.0 \text{ V}$
$V_{CEO(sus)}$	Collector to Emitter Sustaining Voltage (Notes 4 & 5)	15		V	$I_C = 3.0 \text{ mA}, I_B = 0$
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage (Note 5)		0.4	V	$I_C = 10 \text{ mA}, I_B = 1.0 \text{ mA}$
$V_{BE(sat)}$	Base to Emitter Saturation Voltage		1.0	V	$I_C = 10 \text{ mA}, I_B = 1.0 \text{ mA}$
C_{ob}	Output Capacitance		1.7 3.0	pF	$V_{CB} = 10 \text{ V}, I_E = 0, f = 1.0 \text{ MHz}$ $V_{CB} = 0, I_E = 0, f = 1.0 \text{ MHz}$
C_{ib}	Input Capacitance		1.6	pF	$V_{EB} = 0.5 \text{ V}, I_C = 0, f = 1.0 \text{ MHz}$

FAIRCHILD SEMICONDUCTOR

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PN918/MPS918/FTSO918
PN3563/MPS3563/FTSO3563

T-31-23

ELECTRICAL CHARACTERISTICS (25° C Ambient Temperature unless otherwise noted) (Note 6)

SYMBOL	CHARACTERISTIC	PN918		UNITS	TEST CONDITIONS
		MIN	MAX		
h_{fe}	High Frequency Current Gain	6.0			$I_c = 4.0 \text{ mA}, V_{ce} = 10 \text{ V},$ $f = 100 \text{ MHz}$
G_{pe}	Available Power Gain (neutralized) (test circuit 254 for PN918)	15		dB	$I_c = 6.0 \text{ mA}, V_{ce} = 12 \text{ V},$ $f = 200 \text{ MHz}$
P_o	Power Output (test circuit no. 264)	30		mW	$I_c = 8.0 \text{ mA}, V_{ce} = 15 \text{ V},$ $f = 500 \text{ MHz}$
η	Collector Efficiency	25		%	$I_c = 8.0 \text{ mA}, V_{ce} = 15 \text{ V},$ $f = 500 \text{ MHz}$
NF	Noise Figure		6.0	dB	$I_c = 1.0 \text{ mA}, V_{ce} = 6.0 \text{ V},$ $f = 60 \text{ kHz}, R_G = 400 \Omega$

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PN3565/FTSO3565 T-29-2-3

NPN Low Level High Gain
Amplifiers

- $V_{CEO} \dots 25$ V (Min)
- $h_{FE} \dots 150\text{-}600 @ 1.0$ mA

PACKAGE
 PN3565 TO-92
 FTSO3565 TO-236AA/AB

ABSOLUTE MAXIMUM RATINGS (Note 1)**Temperatures**

Storage Temperature -55°C to 150°C
 Operating Junction Temperature 150°C

**Power Dissipation (Note 2)**

Total Dissipation at	PN	FTSO
25°C Ambient Temperature	0.625 W	0.350 W*
25°C Case Temperature	1.0 W	

Voltages & Currents

V_{CEO} Collector to Emitter Voltage (Note 3)	25 V
V_{CBO} Collector to Base Voltage	30 V
V_{EBO} Emitter to Base Voltage	6.0 V
I_C Collector Current	50 mA

ELECTRICAL CHARACTERISTICS (25°C Ambient Temperature unless otherwise noted) (Note 4)

SYMBOL	CHARACTERISTIC	MIN	MAX	UNITS	TEST CONDITIONS
BV_{CBO}	Collector to Base Breakdown Voltage	30		V	$I_C = 100 \mu A, I_E = 0$
BV_{EBO}	Emitter to Base Breakdown Voltage	6.0		V	$I_C = 0, I_E = 10 \mu A$
I_{CBO}	Collector Cutoff Current		50	nA	$V_{CB} = 25$ V, $I_E = 0$
I_{CBO}	Collector Cutoff Current		3.0	μA	$V_{CE} = 25$ V, $I_E = 0, T_A = 65^\circ C$
h_{FE}	DC Current Gain	150 70	600		$I_C = 1.0$ mA, $V_{CE} = 10$ V $I_C = 100 \mu A, V_{CE} = 10$ V
$V_{CEO(sus)}$	Collector to Emitter Sustaining Voltage	25		V	$I_C = 2.0$ mA, $I_B = 0$
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage		0.35	V	$I_C = 1.0$ mA, $I_B = 0.1$ mA
C_{ob}	Open Circuit Output Capacitance		40	pF	$I_E = 0, V_{CB} = 5.0$ V, $f = 140$ kHz
h_{fe}	High Frequency Current Gain	2.0	12		$I_C = 1.0$ mA, $V_{CE} = 5.0$ V, $f = 20$ MHz
h_{ie}	Input Resistance	2.0	20	kΩ	$I_C = 1.0$ mA, $V_{CE} = 5.0$ V, $f = 1.0$ kHz
h_{oe}	Output Conductance	0.5	100	μmhos	$I_C = 1.0$ mA, $V_{CE} = 5.0$ V, $f = 1.0$ kHz
h_{re}	Small Signal Current Gain	120	750		$I_C = 1.0$ mA, $V_{CE} = 5.0$ V, $f = 1.0$ kHz

NOTES:

1. These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired.
2. These ratings give a maximum junction temperature of 150°C and (TO92) junction-to-case thermal resistance of 125°C/W (derating factor of 8.0 mW/°C); junction-to-ambient thermal resistance of 200°C/W (derating factor of 5.0 mW/°C); (TO236) junction-to-ambient thermal resistance of 357°C/W (derating factor of 2.8 mW/°C).
3. Rating refers to a high current point where collector to emitter voltage is lowest.
4. For product family characteristic curves, refer to Curve Set T155.
- * Package mounted on 99.5% alumina 8 mm x 8 mm x 0.6 mm.

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PN3566/FTSO3566

NPN Small Signal General Purpose
Amplifiers

T-29-23

- V_{CEO} ... 30 V (Min)
- h_{FE} ... 150-600 @ 10 mA
- Complement ... MPS3638A

PACKAGE

PN3566	TO-92
FTSO3566	TO-236AA/AB

ABSOLUTE MAXIMUM RATINGS (Note 1)**Temperatures**

Storage Temperature	-55°C to 150°C
Operating Junction Temperature	150°C

Power Dissipation (Notes 2 & 3)

	PN	FTSO
Total Dissipation at		
25°C Ambient Temperature	0.625 W	0.350 W*
25°C Case Temperature	1.0 W	

Voltages & Currents

V_{CEO} Collector to Emitter Voltage	30 V
(Note 4)	
V_{CBO} Collector to Base Voltage	40 V
V_{EBO} Emitter to Base Voltage	5.0 V
I_C Collector Current	200 mA

ELECTRICAL CHARACTERISTICS (25°C Ambient Temperature unless otherwise noted) (Note 6)

SYMBOL	CHARACTERISTIC	MIN	MAX	UNITS	TEST CONDITIONS
BV_{CBO}	Collector to Base Breakdown Voltage	40		V	$I_C = 100 \mu A, I_E = 0$
BV_{EBO}	Emitter to Base Breakdown Voltage	5.0		V	$I_E = 10 \mu A, I_C = 0$
I_{CB0}	Collector Cutoff Current		50	nA	$V_{CB} = 20 V, I_E = 0$
I_{CB0}	Collector Cutoff Current		5.0	μA	$V_{CB} = 20 V, I_E = 0, T_A = 75^\circ C$
I_{EB0}	Emitter Cutoff Current		10	μA	$V_{EB} = 5.0 V, I_C = 0$
h_{FE}	DC Pulse Current Gain (Note 5)	150 80	600		$I_C = 10 mA, V_{CE} = 10 V$ $I_C = 2.0 mA, V_{CE} = 10 V$

NOTES:

1. These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired.
2. These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.
3. These ratings give a maximum junction temperature of 150°C and (TO-92) junction-to-case thermal resistance of 125°C/W (derating factor of 8.0 mW/°C); junction-to-ambient thermal resistance of 200°C/W (derating factor of 50 mW/°C); (TO-236) junction-to-ambient thermal resistance of 357°C/W (derating factor of 2.8 mW/°C).
4. Rating refers to a high current point where collector to emitter voltage is lowest.
5. Pulse conditions: length = 300 μs; duty cycle ≤ 1%.
6. For product family characteristic curves, refer to Curve Set T145.
- * Package mounted on 99.5% alumina 8 mm x 8 mm x 0.6 mm.

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PN3566/FTSO3566

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ELECTRICAL CHARACTERISTICS (25°C Ambient Temperature unless otherwise noted) (Note 6)

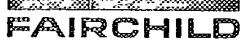
SYMBOL	CHARACTERISTIC	MIN	MAX	UNITS	TEST CONDITIONS
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage (Pulsed) (Note 5)		1.0	V	$I_C = 100 \text{ mA}, I_E = 10 \text{ mA}$
$V_{CEO(sus)}$	Collector to Emitter Sustaining Voltage (Notes 4 & 5)	30		V	$I_C = 30 \text{ mA}, I_B = 0 \text{ (pulsed)}$
$V_{BE(on)}$	Base to Emitter "On" Voltage (pulsed) (Note 5)		0.9	V	$I_C = 100 \text{ mA}, V_{CE} = 1.0 \text{ V}$
C_{ob}	Output Capacitance		25	pF	$V_{CB} = 10 \text{ V}, I_E = 0, f = 140 \text{ kHz}$
h_{fe}	High Frequency Current Gain	2.0	35		$I_C = 30 \text{ mA}, V_{CE} = 10 \text{ V}, f = 20 \text{ MHz}$

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PN3567/FTSO3567

PN3569/FTSO3569

NPN Small Signal General Purpose
Amplifiers

T-29-23

- V_{CEO} ... 40 V (Min)
- h_{FE} ... 100-300 @ 10 mA (3569); 40-120 @ 150 mA (3567)
- Complement ... MPS4355

	PACKAGE
PN3567	TO-92
PN3569	TO-92
FTSO3567	TO-236AA/AB
FTSO3569	TO-236AA/AB

ABSOLUTE MAXIMUM RATINGS (Note 1)**Temperatures**

Storage Temperature -55°C to 150°C
 Operating Junction Temperature 150°C

Power Dissipation (Notes 2 & 3)

	PN	FTSO
25°C Ambient Temperature	0.625 W	0.350 W*
25°C Case Temperature	1.0 W	

Voltages & Currents

V_{CEO}	Collector to Emitter Voltage (Notes 4 & 6)	40 V
V_{CBO}	Collector to Base Voltage	80 V
V_{EBO}	Emitter to Base Voltage	5.0 V
I_C	Collector Current	500 mA
I_B	Base Current	100 mA

ELECTRICAL CHARACTERISTICS (25°C Ambient Temperature unless otherwise noted) (Note 7)

SYMBOL	CHARACTERISTIC	3567		3569		UNITS	TEST CONDITIONS
		MIN	MAX	MIN	MAX		
BV_{CEO}	Collector to Emitter Breakdown Voltage (Note 5)	40		40		V	$I_C = 30 \text{ mA}, I_B = 0$
BV_{CBO}	Collector to Base Breakdown Voltage	80		80		V	$I_C = 100 \mu\text{A}, I_E = 0$
BV_{EBO}	Emitter to Base Breakdown Voltage	5.0		5.0		V	$I_E = 10 \mu\text{A}, I_C = 0$
I_{CBO}	Collector Cutoff Current		50 5.0		50 5.0	nA μA	$V_{CB} = 40 \text{ V}, I_E = 0$ $V_{CB} = 40 \text{ V}, I_E = 0, T_A = 75^\circ\text{C}$
I_{EBO}	Emitter Cutoff Current		25		25	nA	$V_{EB} = 4.0 \text{ V}, I_C = 0$

NOTES:

1. These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired.
2. These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.
3. These ratings give a maximum junction temperature of 150°C and (TO-92) junction-to-case thermal resistance of 125°C/W (derating factor of 8.0 mW/°C); junction-to-ambient thermal resistance of 200°C/W (derating factor of 5.0 mW/°C); (TO-236) junction-to-ambient thermal resistance of 357°C/W (derating factor of 2.8 mW/°C).
4. Rating refers to a high current point where collector to emitter voltage is lowest
5. Pulse conditions: length = 300 μs ; duty cycle = 1%.
6. Applicable 0 to 30 mA.
7. For product family characteristic curves, refer to Curve Set T145.
- * Package mounted on 99.5% alumina 8 mm x 8 mm x 0.6 mm.

FAIRCHILD SEMICONDUCTOR

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PN3567/FTSO3567
PN3569/FTSO3569

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ELECTRICAL CHARACTERISTICS (25°C Ambient Temperature unless otherwise noted) (Note 7)

SYMBOL	CHARACTERISTIC	3567		3569		UNITS	TEST CONDITIONS
		MIN	MAX	MIN	MAX		
h_{FE}	DC Current Gain (Note 5)	40 40	120	100 100	300		$I_C = 150 \text{ mA}, V_{CE} = 1.0 \text{ V}$ $I_C = 30 \text{ mA}, V_{CE} = 1.0 \text{ V}$
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage (Note 5)		0.25		0.25	V	$I_C = 150 \text{ mA}, I_B = 15 \text{ mA}$
$V_{BE(on)}$	Base to Emitter "On" Voltage (Note 5)		1.1		1.1	V	$I_C = 150 \text{ mA}, V_{CE} = 1.0 \text{ V}$
C_{cb}	Collector to Base Capacitance		20		20	pF	$V_{CB} = 10 \text{ V}, I_E = 0, f = 140 \text{ kHz}$
C_{eb}	Emitter to Base Capacitance		80		80	pF	$V_{EB} = 0.5 \text{ V}, I_C = 0, f = 140 \text{ kHz}$
$ h_{re} $	Magnitude of Common Emitter Small Signal Current Gain	3.0	30	3.0	30		$I_C = 50 \text{ mA}, V_{CE} = 10 \text{ V}, f = 20 \text{ MHz}$

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